

<b>Notice of References Cited</b>	Application/Control No. 10/708,345	Applicant(s)/Patent Under Reexamination YANG ET AL.	
	Examiner Hai H. Huynh	Art Unit 3747	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,213,086 B1	04-2001	Chmela et al.	123/276
*	B	US-6,619,254 B2	09-2003	Chmela et al.	123/276
*	C	US-6,640,771 B2	11-2003	Fuerhapter, Alois	123/295
*	D	US-6,752,123 B2	06-2004	Unger et al.	123/305
*	E	US-2003/0131805 A1	07-2003	Yang, Jialin	123/27.00R
*	F	US-2004/0134449 A1	07-2004	Yang, Jialin	123/027.00R
*	G	US-2005/0188955 A1	09-2005	Koopmans, Lucien	123/435
*	H	US-2004/0182359 A1	09-2004	Stewart et al.	123/295
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.